# imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

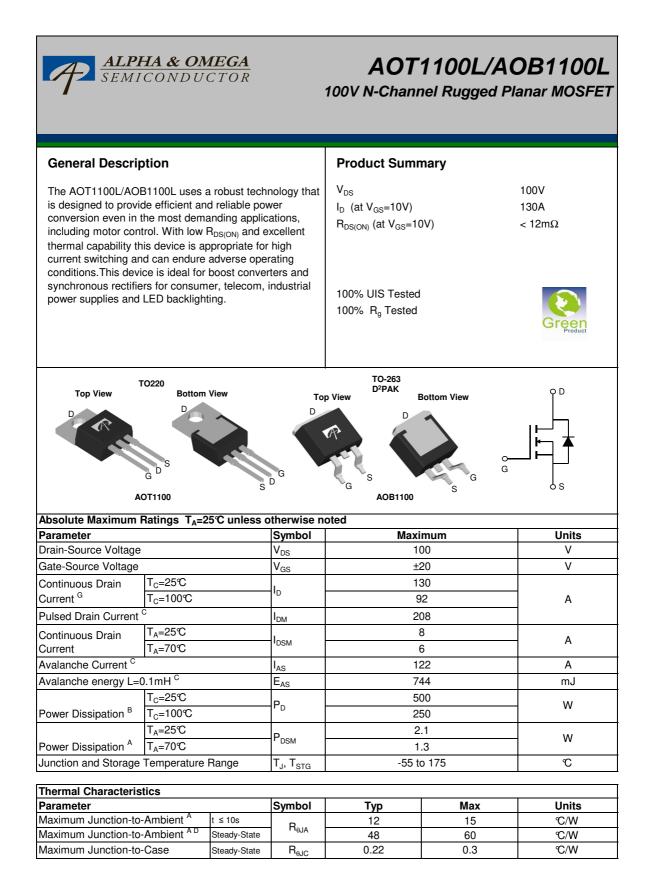
We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



## Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China







#### Electrical Characteristics (T<sub>J</sub>=25<sup>°</sup>C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_{D}=250\mu A, V_{GS}=0V$		100			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V				1	μΑ
			T <sub>J</sub> =55℃			5	
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±20V				100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{D}=250\mu A$		2.6	3.2	3.8	V
I <sub>D(ON)</sub>	On state drain current	$V_{GS}$ =10V, $V_{DS}$ =5V		208			Α
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =20A TO220			10	12	mΩ
			T <sub>J</sub> =125℃		19	22	
		V <sub>GS</sub> =10V, I <sub>D</sub> =20A					
		TO263			9.7	11.7	mΩ
<b>g</b> <sub>FS</sub>	Forward Transconductance	$V_{DS}=5V, I_{D}=20A$			53		S
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V			0.69	1	V
l <sub>s</sub>	Maximum Body-Diode Continuous Curr	ent <sup>G</sup>				130	Α
DYNAMIC	PARAMETERS				-		
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1MHz			4833		pF
C <sub>oss</sub>	Output Capacitance				721		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				35		pF
R <sub>g</sub>	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz		0.5	1.1	1.7	Ω
SWITCHI	NG PARAMETERS						
Q <sub>g</sub> (10V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, I <sub>D</sub> =20A			82	100	nC
Q <sub>gs</sub>	Gate Source Charge				23		nC
$Q_{gd}$	Gate Drain Charge				19		nC
t <sub>D(on)</sub>	Turn-On DelayTime	$V_{GS}$ =10V, $V_{DS}$ =50V, $R_{L}$ =2.5 $\Omega$ , $R_{GEN}$ =3 $\Omega$			21		ns
t <sub>r</sub>	Turn-On Rise Time				22		ns
t <sub>D(off)</sub>	Turn-Off DelayTime				50		ns
t <sub>f</sub>	Turn-Off Fall Time				4.5		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =20A, dI/dt=500A/μs			64		ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =20A, dI/dt=500A/μs			880		nC

A. The value of  $R_{eJA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^{\circ}$  C. The Power dissipation  $P_{DSM}$  is based on R <sub>eJA</sub> and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=175^{\circ}$  C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}$ =175° C. Ratings are based on low frequency and duty cycles to keep initial  $T_{J}$ =25° C. Maximum UIS current limited by test equipment.

D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =175° C. The SOA curve provides a single pulse rating.

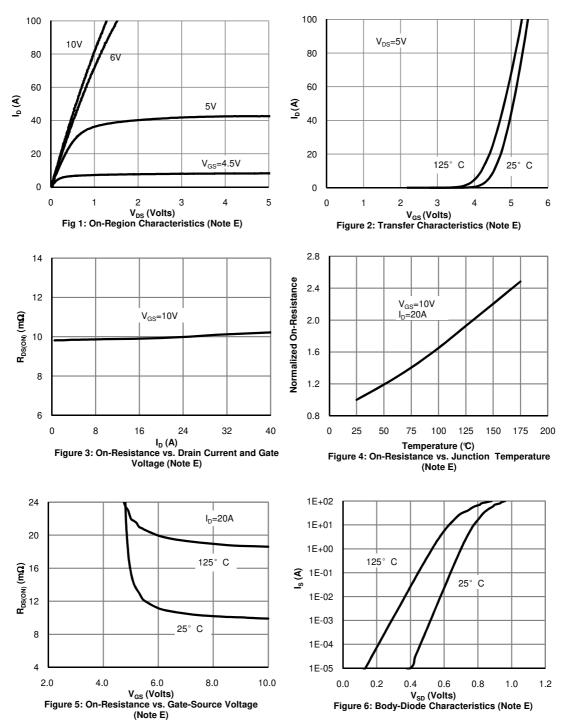
G. The maximum current limited by package.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

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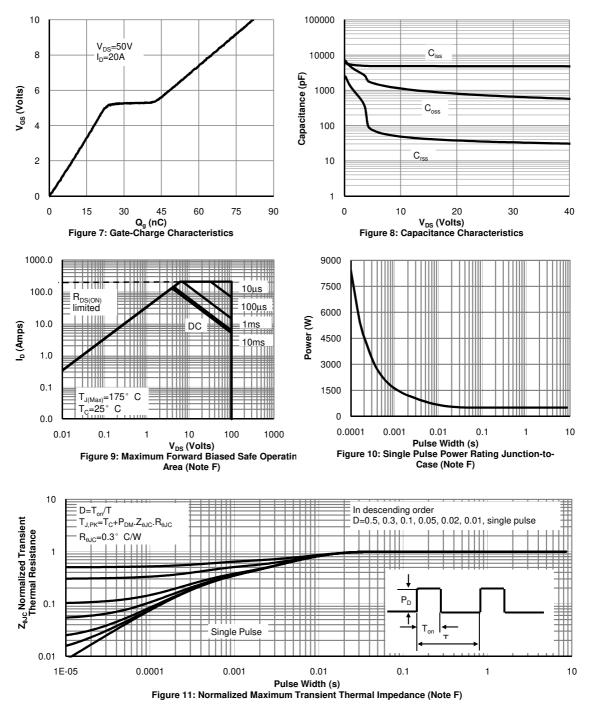


#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



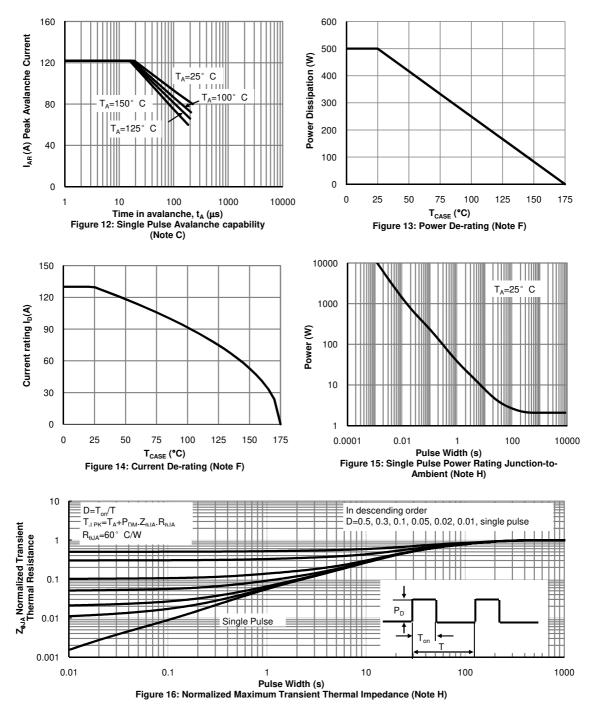


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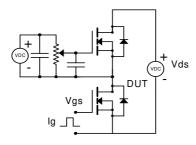


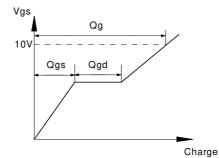
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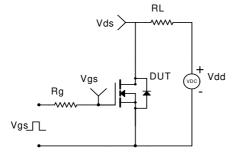


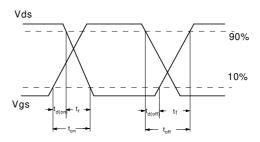
### Gate Charge Test Circuit & Waveform



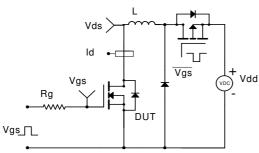


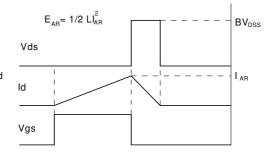
Resistive Switching Test Circuit & Waveforms





#### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





#### Diode Recovery Test Circuit & Waveforms

